## Notice of References Cited

Application/Control No. 10/523,070	Applicant(s)/Patent Under Reexamination YAGI ET AL.		
Examiner	Art Unit		
SHENG HAN	4162	Page 1 of 1	

## U.S. PATENT DOCUMENTS

	O.G. TATERT DOGGMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,139,648	08-1992	Lambert, Susan L.	208/111.15
*	В	US-2002/0169077	11-2002	Bae et al.	502/527.19
*	O	US-2003/0116503	06-2003	Wang et al.	210/660
*	D	US-2003/0226604	12-2003	Schlautmann et al.	137/827
*	Е	US-6,736,983	05-2004	Thies et al.	216/2
*	F	US-6,828,055	12-2004	Kearl, Daniel A.	429/38
*	G	US-7,247,276	07-2007	Schuppich et al.	422/129
*	Н	US-2008/0142036	06-2008	SANCHEZ, Marcel	132/320
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	v						
	w						
	×						

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